

OLIMITOT 2

IGBT Module

SK50GARL065

Preliminary Data

Features

- Compact design
- · One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- N-channel homogeneous silicon structure (NPT-Non punch-through IGBT)
- Low tail current with low temperature dependence
- · Low threshold voltage

Typical Applications

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



Absolute Maximum Ratings $T_s = 25 ^{\circ}\text{C}$, unless otherwise specified						
Symbol	Conditions			Values	Units	
IGBT						
V_{CES}	$T_j = 25 ^{\circ}\text{C}$ $T_i = 125 ^{\circ}\text{C}$			600	V	
I _C	T _j = 125 °C	T _s = 25 °C		54	Α	
		T_s = 80 °C		40	Α	
I _{CRM}	I _{CRM} = 2 x I _{Cnom}			120	Α	
V_{GES}				± 20	V	
t _{psc}	V_{CC} = 300 V; $V_{GE} \le 20$ V; $V_{CES} < 600$ V	T _j = 125 °C		10	μs	
Inverse D	iode				•	
I _F	T _j = 150 °C	$T_s = 25 ^{\circ}C$		25	Α	
		T_s = 80 °C		17	Α	
I _{FRM}	I _{FRM} = 2 x I _{Fnom}				Α	
I _{FSM}	t _p = 10 ms; half sine wave	T _j = 150 °C		100	Α	
Freewhee	eling Diode					
I _F	T _j = 150 °C	$T_s = 25 ^{\circ}C$		64	Α	
		T_s = 80 °C		48	Α	
I _{FRM}					Α	
I _{FSM}	t _p = 10 ms; half sine wave	T _j = 150 °C		400	Α	
Module						
$I_{t(RMS)}$					Α	
T_{vj}				-40 + 150	°C	
T _{stg}				-40 + 125	°C	
V _{isol}	AC, 1 min.			2500	V	

Characteristics T _s =			25 °C, unless otherwise specified				
Symbol	Conditions		min.	typ.	max.	Units	
IGBT							
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 0.7 \text{ mA}$		3	4	5	V	
I _{CES}	V_{GE} = 600 V, V_{CE} = V_{CES}	T _j = 25 °C			0,0022	mA	
I _{GES}	$V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}$	T _j = 25 °C			120	nA	
V_{CE0}		T _j = 25 °C		1,2	1,3	V	
		T _j = 125 °C		1,1	1,2	V	
r _{CE}	V _{GE} = 15 V	T _j = 25°C			12	mΩ	
		T _j = 125°C			22	mΩ	
V _{CE(sat)}	I _{Cnom} = 60 A, V _{GE} = 15 V			1,7	2	V	
		$T_j = 125^{\circ}C_{chiplev.}$		2,2	2,2	V	
C _{ies}				3,2		nF	
C _{oes}	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,3		nF	
C _{res}				0,18		nF	
Q_G	V _{GE} =0 20 V			375		nC	
t _{d(on)}				47		ns	
t _r	$R_{Gon} = 15 \Omega$	V _{CC} = 300V		60	80	ns	
E _{on}	D 100	I _C = 40A		1,07	1,4	mJ	
t _{d(off)}	$R_{Goff} = 16 \Omega$	T _j = 125 °C		220	280	ns	
t _f		V _{GE} = ±15V		20	26	ns	
E _{off}				0,76	1	mJ	
$R_{\text{th(j-s)}}$	per IGBT				0,85	K/W	



SEMITOP® 2

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Characteristics								
Symbol	Conditions	İ	min.	typ.	max.	Units		
Inverse Diode								
$V_F = V_{EC}$	$I_{Fnom} = 15 \text{ A}; V_{GE} = 0 \text{ V}$			1,4	1,7	V		
		$T_j = 125 ^{\circ}C_{\text{chiplev.}}$		1,4	1,7	V		
V_{F0}		T _j = 125 °C		0,9	1	V		
r _F		T _j = 125 °C		33	47	mΩ		
I _{RRM} Q _{rr}	I _F = 30 A di/dt = 500 A/μs	T _j = 125 °C				Α μC		
E _{rr}	V _{CC} =300V					mJ		
R _{th(j-s)D}	per diode				2,3	K/W		
	Freewheeling diode							
$V_F = V_{EC}$	$I_{Fnom} = 60 \text{ A}; V_{GE} = 0 \text{ V}$			1,45	1,7	V		
		T _j = 150 °C _{chiplev} .		1,4	1,75	V		
V _{F0}		T _j = 125 °C		0,85	0,9	V		
r _F		T _j = 125 °C		11	16	V		
I _{RRM}	I _F = 50 A	T _j = 125 °C		40		Α		
Q_{rr}	di/dt = -1000 A/μs	-		3,6		μC		
E _{rr}	V _R =300V			0,55		mJ		
$R_{th(j-s)D}$	per diode				1,1	K/W		
M_s	to heat sink		1,8		2	Nm		
w				19		g		

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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